Application/Control No. Applicant(s)/Patent Under Reexamination 10/560,145 FORNARA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Brian P. Mruk 1751 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code Name Classification MM-YYYY US-US-В US-C US-D US-Ε US-F US-G USн US-1 US-J Κ US-US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO 86/05187 09-1986 Ν Europe Howell C07H 3/00 WO 2004/111170 0 12-2004 Europe Fornara et al C11D 3/386 P-Q R s Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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